

<b>Notice of References Cited</b>	Application/Control No. 09/664,180	Applicant(s)/Patent Under Reexamination CHAPMAN ET AL.	
	Examiner Huy D Nguyen	Art Unit 2681	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,987,318	11-1999	Alperovich et al.	455/416
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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